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SPEC. No. C-ULI-b D A T E : Jun, 2019

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# **Non-Controlled Copy**

CUSTOMER'S PRODUCT NAME

TDK PRODUCT NAME Multilayer Ceramic Chip Capacitors Ultra Low Inductance Bulk and Tape packaging [RoHS compliant] CLLC1A Type X6S,X7R,X7S Characteristics

Please return this specification to TDK representatives with your signature. If orders are placed without returned specification, please allow us to judge that specification is accepted by your side.

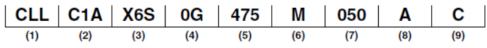
# **RECEIPT CONFIRMATION**

DATE:	YEAR	MONTH	DAY
DAIL.			DAI

TDK Corporation Sales Electronic Components Sales & Marketing Group

Engineering Electronic Components Business Company Ceramic Capacitors Business Group

### CATALOG NUMBER CONSTRUCTION



(1) Series

### (2) Dimensions L x W (mm)

Dimensions code	EIA	Length	Width	Terminal width
C1A	CC0603	1.60	0.80	0.25
E1A	CC0805	2.00	1.25	0.25
G1A	CC1206	3.20	1.60	0.40

#### (3) Temperature characteristics

Temperature characteristics	Capacitance change	Temperature range
X6S	±22%	-55 to +105°C
X7R	±15%	-55 to +125°C
X7S	±22%	-55 to +125°C

#### (4) Rated voltage (DC)

Code	Voltage (DC)
0G	4V
0J	6.3V
1A	10V

#### (5) Nominal capacitance (pF)

The capacitance is expressed in three digit codes and in units of pico Farads (pF). The first and second digits identify the first and second significant figures of the capacitance. The third digit identifies the multiplier. R designates a decimal point.

(Example)0R5 = 0.5pF
101 = 100pF
225 = 2,200,000pF = 2.2µF

#### (6) Capacitance tolerance

Code	Tolerance	
М	±20%	

#### (7) Thickness

Thickness	
0.50mm	
0.85mm	
	0.50mm

#### (8) Packaging style

Code	Style
A	178mm reel, 4mm pitch

#### (9) Special reserved code

Code	Description
С	TDK internal code

### SCOPE

This delivery specification shall be applied to Multilayer ceramic chip capacitors to be delivered to

### **PRODUCTION PLACES**

Production places defined in this specification shall be TDK Corporation, TDK(Suzhou)Co.,Ltd and TDK Components U.S.A.,Inc.

#### PRODUCT NAME

The name of the product to be defined in this specifications shall be <u>CLLC1AOOO $\triangle \triangle \Box \Box \Box \times$ </u>.

### **REFERENCE STANDARD**

Fixed capacitors for use in electronic equipment-Part 1: Generic specification
Fixed capacitors for use in electronic equipment-Part 22 : Sectional specification
: Fixed surface mount multilayer capacitors of ceramic dielectric, Class2
Packaging of components for automatic handling - Part 3: Packaging of
surface mount components on continuous tapes
Safety application guide for fixed ceramic capacitors for use in electronic
equipment

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- 10. SOLDERING CONDITION
- 11. CAUTION
- 12. TAPE PACKAGING SPECIFICATION
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### <EXPLANATORY NOTE>

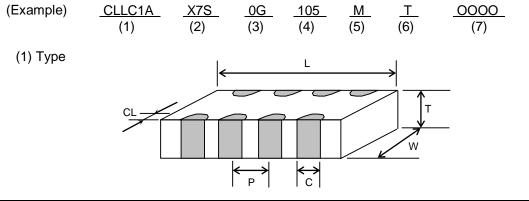
When the mistrust in the spec arises, this specification is given priority. And it will be confirmed by written spec change after conference of both posts involved.

This specification warrants the quality of the ceramic chip capacitor. Capacitors should be evaluated or confirmed a state of mounted on your product.

If the use of the capacitors goes beyond the bounds of this specification, we can not afford to guarantee.

Division	Date	SPEC. No.
Ceramic Capacitors Business Group	Jun, 2019	C-ULI-b

### **1. CODE CONSTRUCTION**



Case size	Dimensions (Unit : mm)						
[EIA style]	L	W	Т	Р	С	CL	
CLLC1A [CC0603]	1.60 ± 0.10	0.80 ± 0.10	0.50 <sup>+0.05</sup> - 0.10	0.40 ± 0.10	0.25 ± 0.10	0.15 ± 0.10	

\* As for each item, please refer to detail page on TDK Web.

- (2) Temperature Characteristics
  - \* Details are shown in table 1 No.6 at 6.PERFORMANCE
- (3) Rated Voltage

Symbol	Rated Voltage		
0G	DC 4 V		

(Example)

Symbol

Т

(4) Rated Capacitance

Stated in three digits and in units of pico farads (pF). The first and Second digits identify the first and second significant figures of the capacitance, the third digit identifies the multiplier.

105	1,000,000 pF

Rated

Capacitance

Taping

(5) Capacitance tolerance	Symbol	Tolerance
	М	± 20 %
(6) Packaging	Symbol	Packaging
	В	Bulk

(7) TDK internal code

### 2. COMBINATION OF RATED CAPACITANCE AND TOLERANCE

Temperature Characteristics	Capacitance tolerance	Rated capacitance
X6S X7R X7S	M (± 20 %)	E – 6 series

Capacitance Step in E series

E series		Capacitance Step						
E- 6	1.0	1.5	2.2	3.3	4.7	6.8		

### **3. OPERATING TEMPERATURE RANGE**

T.C.	Min. operating Temperature	Max. operating Temperature	Reference Temperature
X6S	-55°C	105°C	25°C
X7R X7S	-55°C	125°C	25°C

### 4. STORING CONDITION AND TERM

Storing temperature	Storing humidity	Storing term
5~40°C	20~70%RH	Within 6 months upon receipt.

### 5. INDUSTRIAL WASTE DISPOSAL

Dispose this product as industrial waste in accordance with the Industrial Waste Law.

### 6. PERFORMANCE

		table 1	
No.	Item	Performance	Test or inspection method
1	External Appearance	No defects which may affect performance.	Inspect with magnifying glass(3x)
2	Insulation Resistance	100MΩ·µF min.	Measuring voltage : Rated voltage Voltage application time : 60s. Measure 8 terminal electrodes at the same time.
3	Voltage Proof	Withstand test voltage without insulation breakdown or other damage.	Applied voltage : 2.5 times of rated voltage Above DC voltage shall be applied between each terminal in equivalent circuit for 1s. Charge / discharge current : 50mA or lower
4	Capacitance	Within the specified tolerance.	
			Measuring Measuring frequency voltage
			1kHz±10% 0.5±0.2Vrms.
			Measure 8 terminal electrodes at the same time.
5	Dissipation Factor	Please refer to detail page on TDK Web.	See No.4 in this table for measuring condition.
6	Temperature Characteristics of Capacitance	Capacitance Change (%) No voltage applied X6S : ±22 X7R : ±15 X7S : ±22	Capacitance shall be measured by the steps shown in the following table after thermal equilibrium is obtained for each step. Capacitance change shall be calculated by the value of the reference temperature in Step 3. <u>Step Temperature(°C)</u> <u>1 Reference temp. ± 2</u> <u>2 Min. operating temp. ± 2</u> <u>3 Reference temp. ± 2</u> <u>4 Max. operating temp. ± 2</u> <u>4 Max. operating temp and Reference temp., please refer to "3.OPERATING TEMPERATURE RANGE" As for measuring voltage, please contact with our sales representative.</u>

(continued)

No.	lt	em	Perfo	rmance	Test o	r inspection method	
7	7 Robustness of Terminations		5		Reflow solder the capacitors on a P.C.Board shown in Appendix1. Apply a pushing force gradually at the center of a specimen in a horizontal direction of P.C.Board. Pushing force : 5N Holding time : $10\pm1s$		
8	8 Solderability		All terminations shall exhibit a continuous solder coating free from defects for a minimum of 75% of the surface area of any individual termination. Anomalies other than dewetting, non-wetting, and pin holes are not cause for rejection.		Solder : Flux : Solder temp. : Dwell time : Solder position :	Sn-3.0Ag-0.5Cu or Sn-37Pb Isopropyl alcohol (JIS K 8839) Rosin (JIS K 5902) 25% solid solution. 245±5°C (Sn-3.0Ag-0.5Cu) 235±5°C (Sn-37Pb) 3±0.3s.(Sn-3.0Ag-0.5Cu) 2±0.2s.(Sn-37Pb) Until both terminations are completely soaked.	
9	Resistance to solder heat	External appearance Capacitance D.F. Insulation Resistance	No cracks are al terminations sha least 60% with n Characteristics X6S X7R X7S Meet the initial s Meet the initial s	Il be covered at ew solder. Change from the value before test ± 7.5 % pec.		Sn-3.0Ag-0.5Cu or Sn-37PbIsopropyl alcohol (JIS K 8839) Rosin (JIS K 5902) 25% solid solution. $260\pm5^{\circ}C$ $10\pm1s$ .Until both terminations are completely soaked.Temp. — 110~140°C Time — $30\sim60s$ .acitors in ambient condition re measurement.	

No.	lte	em	Perfo	ormance		Test or inspection	method	
10	Vibration	External appearance	No mechanical damage.		Frequency : 10~55~10Hz Reciprocating sweep time : 1 min.			
		Capacitance	Characteristics	Change from the value before test	Repea	Amplitude : 1.5mm Repeat this for 2h each in 3 perpendicular directions(Total 6h).		
			X6S X7R X7S	± 7.5 %		v solder the capacit bard shown in Appe		
		D.F.	Meet the initial s	pec.	— testing	- testing.		
11	Temperature cycle	External appearance	No mechanical o	lamage.	Expose the capacitors step1 through step 4 li following table.			
		Capacitance		Change from the		cycle : 5 cycles		
			Characteristics	Change from the value before test	Step	Temperature(°C)	Time (min.)	
			X6S X7R X7S	Please contact with our sales representative.	1	Min. operating temp.±3	30 ± 3	
					2	Ambient Temp.	2 ~ 5	
		D.F.	Meet the initial s	pec.	3 Max. oper temp.±2	Max. operating temp.±2	30 ± 2	
		Insulation Resistance	Meet the initial spec.		4	Ambient Temp.	2 ~ 5	
		Voltage proof	No insulation breakdown or other damage.		As for Min./Max. operating temp., please refer to "3. OPERATING TEMPERATURE RANGE" Leave the capacitors in ambient condition for 24±2h before measurement.			
					Reflov	v solder the capacit bard shown in Appe		
12	Moisture Resistance	External appearance	No mechanical o	lamage.		emp. : 40±2°C umidity : 90~95%Rl	н	
	(Steady State)	Capacitance		Change from the		Test time : 500 +24,0h		
	Olale)		Characteristics	value before test	Leave the capacitors in ambient condition for 24±2h before			
			X6S X7R X7S	Please contact with our sales representative.	measurement.			
		D.F.	200% of initial sp	bec. max.	P.C.Bo	v solder the capacit pard shown in Appe		
		Insulation Resistance	10MΩ·μF min.		testing	J.		

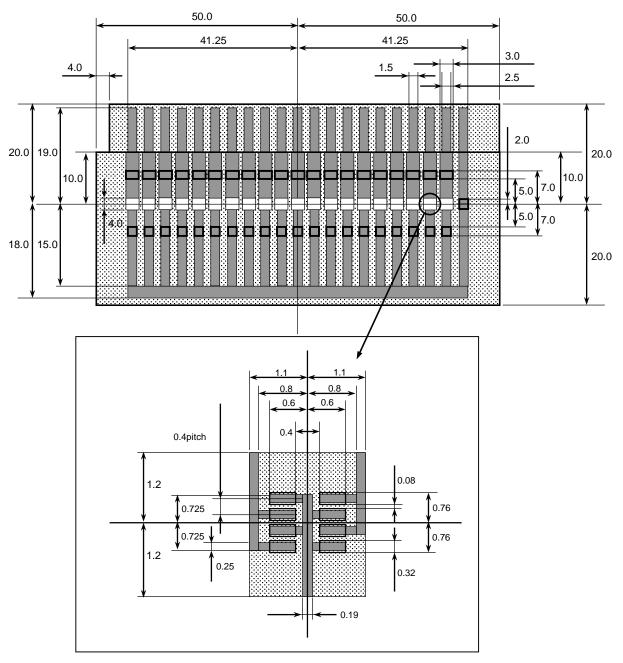
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No.	Item		Perfo	ormance	Test or inspection method
13	Moisture Resistance	External appearance	No mechanical c	lamage.	Test temp. : 40±2°C Test humidity : 90~95%RH Applied voltage : Rated voltage
		Capacitance	Characteristics X6S X7R X7S	Change from the value before test Please contact with our sales representative.	Test time : 500 +24,0h Charge/discharge current : 50mA or lower Leave the capacitors in ambient condition for 24±2h before measurement. Reflow solder the capacitors on a P.C.Board shown in Appendix1 before testing.
		D.F.	200% of initial sp	bec. max.	_ Initial value setting
		Insulation Resistance	5MΩ-µF min.		Voltage conditioning 《After voltage treat the capacitors under testing temperature and voltage for 1 hour,》 leave the capacitors in ambient condition for 24±2h before measurement. Use this measurement for initial value.
14	Life	External appearance	No mechanical c	lamage.	Test temp. : Maximum operating temperature±2°C
		Capacitance			<ul> <li>Applied voltage : Please contact with our sales representative.</li> </ul>
			Characteristics	Change from the value before test	Test time : 1,000 +48,0h
			X6S X7R X7S	Please contact with our sales representative.	Charge/discharge current : 50mA or lower Leave the capacitors in ambient condition for 24±2h before measurement.
		D.F.	200% of initial sp	pec. max.	Reflow solder the capacitors on a P.C.Board shown in Appendix1 before
		Insulation Resistance	10MΩ·µF min.		testing. Initial value setting
					Voltage conditioning 《After voltage treat the capacitors under testing temperature and voltage for 1 hour,》 leave the capacitors in ambient condition for 24±2h before measurement. Use this measurement for initial value.

\*As for the initial measurement of capacitors on number 6,9,10,11 and 12, leave capacitors at 150 0,-10°C for 1h and measure the value after leaving capacitors for 24±2h in ambient condition.

# Appendix1 CLLC1A

P.C. Board for reliability test



(Unit: mm)

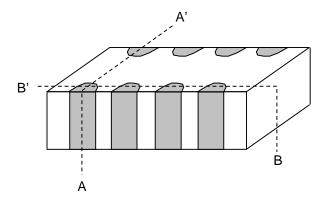
- 1. Material : Glass Epoxy (As per JIS C6484 GE4)
- 2. Thickness : 0.8mm

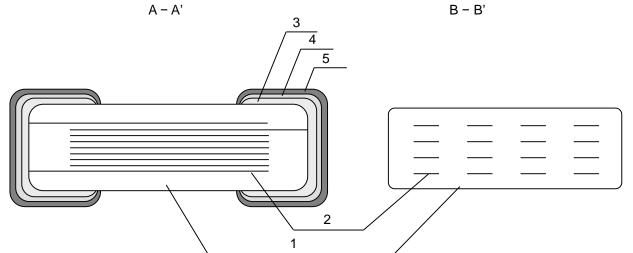
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Copper (Thickness: 0.035mm)

Solder resist

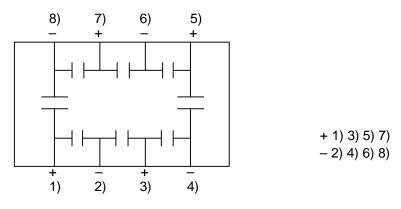
# 7. INSIDE STRUCTURE AND MATERIAL





No.	NAME	MATERIAL
1	Dielectric	BaTiO₃
2	Electrode	Nickel (Ni)
3		Copper (Cu)
4	Termination	Nickel (Ni)
5		Tin (Sn)

# **8. EQUIVALENT CIRCUIT**



8 terminals are connected and measured at the same time.

## 9. PACKAGING

Packaging shall be done to protect the components from the damage during transportation and storing, and a label which has the following information shall be attached.

- 9.1 Each plastic bag for bulk packaging contains 1000pcs. And the minimum quantity for Bulk packaging is 1000pcs.
- 9.2 Tape packaging is as per 12. TAPE PACKAGING SPECIFICATION.
  - 1) Inspection No.\*
  - 2) TDK P/N
  - 3) Customer's P/N
  - 4) Quantity

\*Composition of Inspection No.

Example	<u>F</u>	<u>9</u>	<u>A</u>	—	<u>23</u>	-	<u>001</u>
	(a)	(b)	(c)		(d)		(e)

- (a) Line code
- (b) Last digit of the year
- (c) Month and A for January and B for February and so on. (Skip I)
- (d) Inspection Date of the month.
- (e) Serial No. of the day

\*Composition of new Inspection No. (Will be implemented on and after May 1, 2019)

Example



- (a) Prefix
- (b) Line code
- (c) Last digit of the year
- (d) Month and A for January and B for February and so on. (Skip I)
- (e) Inspection Date of the month.
- (f) Serial No. of the day(00 ~ ZZ)
- (g) Suffix(00  $\sim$  ZZ)

\*It is planned to shift to the new inspection No. on and after May 2019, but the implementation timing may be different depending on shipment bases.

Until the shift is completed, either current or new composition of inspection No. will be applied.

## **10. SOLDERING CONDITION**

Reflow soldering only.

# 11. CAUTION

No.	Process	Condition
1	Operating Condition (Storage, Use,	<ul> <li>1-1. Storage, Use</li> <li>1) The capacitors must be stored in an ambient temperature of 5 to 40°C with a relative humidity of 20 to 70%RH. The products should be used within 6 months upon receipt.</li> </ul>
	Transportation)	<ol> <li>The capacitors must be operated and stored in an environment free of dew condensation and these gases such as Hydrogen Sulphide, Hydrogen Sulphate, Chlorine, Ammonia and sulfur.</li> </ol>
		<ul> <li>3) Avoid storing in sun light and falling of dew.</li> <li>4) Do not use conscitute under birth humidity and high and law atmospheric pressure.</li> </ul>
		4) Do not use capacitors under high humidity and high and low atmospheric pressure which may affect capacitors reliability.
		<ul><li>5) Capacitors should be tested for the solderability when they are stored for long time.</li><li>1-2. Handling in transportation</li></ul>
		In case of the transportation of the capacitors, the performance of the capacitors may be deteriorated depending on the transportation condition. (Refer to JEITA RCR-2335C 9.2 Handling in transportation)
2	Circuit design	<ul> <li>2-1. Operating temperature Operating temperature should be followed strictly within this specification, especially be careful with maximum temperature.</li> <li>1) Do not use capacitors above the maximum allowable operating temperature.</li> </ul>
		2) Surface temperature including self heating should be below maximum operating temperature. (Due to dielectric loss, capacitors will heat itself when AC is applied. Especially at high frequencies around its SRF, the heat might be so extreme that it may damage itself or the product mounted on. Please design the circuit so that the maximum temperature of the capacitors including the self heating to be below the maximum allowable operating temperature. Temperature rise at capacitor surface shall be below 20°C)
		<ol> <li>3) The electrical characteristics of the capacitors will vary depending on the temperature. The capacitors should be selected and designed in taking the temperature into consideration.</li> <li>2-2. Operating voltage</li> <li>1) Operating voltage across the terminals should be below the rated voltage. When AC and DC are super imposed, V<sub>0-P</sub> must be below the rated voltage.</li> </ol>
		AC or pulse with overshooting, $V_{P-P}$ must be below the rated voltage. (1) and (2)
		(3), (4) and (5) When the voltage is started to apply to the circuit or it is stopped applying, the irregular voltage may be generated for a transit period because of resonance or switching. Be sure to use the capacitors within rated voltage containing these Irregular voltage.
		Voltage     (1) DC voltage     (2) DC+AC voltage     (3) AC voltage
		Positional Measurement (Rated voltage) $V_{0-P}$ $V_{0-$
		Voltage     (4) Pulse voltage (A)     (5) Pulse voltage (B)
		Positional Measurement (Rated voltage)

No.	Process	Condition						
2	Circuit design	2) Even below the rated voltage, if repetitive high frequency AC or pulse is applied, the reliability of the capacitors may be reduced.						
		<ol> <li>The effective capacitance will vary depending on applied DC and AC voltages. The capacitors should be selected and designed in taking the voltages into consideration.</li> </ol>						
		2-3. Frequency When the capacitors are used in AC and/or pulse voltages, the capacitors may vibrate themselves and generate audible sound.						
3	Designing P.C. board	The amount of solder at the terminations has a direct effect on the reliability of the capacitors.						
		<ol> <li>The greater the amount of solder, the higher the stress on the chip capacitor, and the more likely that it will break. When designing a P.C. board, determine the shape and size of the solder lands to have proper amount of solder on the terminations.</li> </ol>						
		<ol> <li>Avoid using common solder land for multiple terminations and provide individual solder land for each terminations.</li> </ol>						
		3) Size and recommended land dimensions.						
		B ↓ A						
		$\left  \begin{array}{c} \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\$						
		Recommended Land Dimensions (Unit : mm)						
		Case size CLLC1A Symbol [CC0603]						
		A 0.25						
		B 0.40 C 1.20						
		D 0.40						
		P 0.40						

No.	Process			Condition				
3	Designing P.C.board	4)	Recommended chip capacitor layout is as following.					
	P.C.DOard			Disadvantage against bending stress	Advantage against bending stress			
			Mounting face	Perforation or slit	Perforation or slit			
				Break P.C.board with mounted side up.	Break P.C.board with mounted side down.			
				Mount perpendicularly to perforation or slit	Mount in parallel with perforation or slit			
			Chip arrangement (Direction)	Perforation or slit	Perforation or slit			
			Distance from slit	Closer to slit is higher stress	Away from slit is less stress			
				$(l_1 < l_2)$	$( \mathfrak{Q}_1 < \mathfrak{Q}_2 )$			

No.	Process	Condition
3	Designing P.C.board	5) Mechanical stress varies according to location of chip capacitors on the P.C.board.
		Perforation
		B
		The stress in capacitors is in the following order. A > B = C > D > E
4	Mounting	<ul> <li>4-1. Stress from mounting head</li> <li>If the mounting head is adjusted too low, it may induce excessive stress in the chip capacitor to result in cracking. Please take following precautions.</li> <li>1) Adjust the bottom dead center of the mounting head to reach on the P.C.board surface and not press it.</li> </ul>
		<ul> <li>2) Adjust the mounting head pressure to be 1 to 3N of static weight.</li> <li>3) To minimize the impact energy from mounting head, it is important to provide support from the bottom side of the P.C.board. See following examples.</li> </ul>
		Not recommended Recommended
		Single-sided mounting
		Double-sides mounting Solder peeling Crack
		When the centering jaw is worn out, it may give mechanical impact on the capacitor to cause crack. Please control the close up dimension of the centering jaw and provide sufficient preventive maintenance and replacement of it.

No.	Process	Condition						
5	Soldering	5-1. Flux selection Flux can seriously affect the performance of capacitors. Confirm the following to select the appropriate flux.						
		<ol> <li>It is recommended to use a mildly activated rosin flux (less than 0.1wt% chlorine) Strong flux is not recommended.</li> </ol>						
		2) Excessive flux must be avoided. Please provide proper amount of flux.						
		3) When water-soluble flux is used, enough washing is necessary.						
		5-2. Recommended soldering profile by various methods						
		Reflow soldering						
		Soldering Preheating Natural cooling						
		Peak Temp Ω 2 ΔT						
		Lambda CO Lambda Lambda Lambda Lambda Lambda						
		0 []   ← Over 60 sec. →     ← →   Peak Temp time						
		Manual soldering (Solder iron)						
		300 Ω α μ Preheating						
		0 3sec. (As short as possible)						
		5-3. Recommended soldering peak temp and peak temp duration						
		Temp./Duration Reflow soldering						
		Solder Peak temp(°C) Duration(sec.)						
		Sn-Pb Solder 230 max. 20 max.						
		Lead Free Solder 260 max. 10 max.						
		Recommended solder compositions Lead Free Solder : Sn-3.0Ag-0.5Cu Sn-Pb Solder : Sn-37Pb						

0.	Process		Cond	ition					
5	Soldering	5-4. Avoiding thermal shock							
		1) Preheating condition							
		Soldering	Temp	o. (°C)					
		Reflow solder	ring ∆T ≦	≦ 150					
		Manual solde	ring ∆T ≦	≦ 150					
		<ol> <li>Cooling condition</li> <li>Natural cooling usir</li> <li>for cleaning, the ten</li> </ol>	-		are dipped into a solven ess than 100°C.				
		5-5. Amount of solder							
			ges and it may resu	ult in chip cracking	n chip capacitors wher g. In sufficient solder may				
		Excessivesolder	and the	U	her tensile force in p capacitors to cause ck				
		Adequate	and the second s	Maximum amo					
		Insufficient solder		cau chi	v robustness may use contact failure or p capacitors come off P.C.board.				
		<ul> <li>5-6. Solder repair by sold</li> <li>1) Selection of the solde Tip temperature of so solder land size. The higher However, heat shock Please make sure th time in accordance w</li> </ul>	ring iron tip older iron varies by r the tip temperatur c may cause a crac e tip temp. before vith following recor	re, the quicker the ck in the chip capa soldering and kee nmended conditio	e operation. acitors. ep the peak temp and on.				
		Temp. (°C)	Duration (sec.)	Wattage (W)	Shape (mm)				
				,					
		300 max. * Please preheat the thermal sh		20 max. ors with the condit	Ø 3.0 max. tion in 5-4 to avoid				
					ric of chip capacitors d the terminations by				

No.	Process	Condition
5	Soldering	<ul> <li>5-7. Sn-Zn solder</li> <li>Sn-Zn solder affects product reliability. Please contact TDK in advance when utilize Sn-Zn solder.</li> <li>5-8. Countermeasure for tombstone The misalignment between the mounted positions of the capacitors and the land patterns should be minimized. The tombstone phenomenon may occur especially the capacitors are mounted (in longitudinal direction) in the same direction of the reflow soldering. (Refer to JEITA RCR-2335C Annex A (Informative) Recommendations to prevent the tombstone phenomenon)</li> </ul>
6	Cleaning	<ol> <li>If an unsuitable cleaning fluid is used, flux residue or some foreign articles may stick to chip capacitors surface to deteriorate especially the insulation resistance.</li> </ol>
		2) If cleaning condition is not suitable, it may damage the chip capacitors.
		<ul><li>2)-1. Insufficient washing</li><li>(1) Terminal electrodes may corrode by Halogen in the flux.</li></ul>
		(2) Halogen in the flux may adhere on the surface of capacitors, and lower the insulation resistance.
		<ul><li>(3) Water soluble flux has higher tendency to have above mentioned problems</li><li>(1) and (2).</li></ul>
		2)-2. Excessive washing
		When ultrasonic cleaning is used, excessively high ultrasonic energy output can affect the connection between the ceramic chip capacitor's body and the terminal electrode. To avoid this, following is the recommended condition.
		Power : 20 W/L max. Frequency : 40 kHz max. Washing time : 5 minutes max.
		2)-3. If the cleaning fluid is contaminated, density of Halogen increases, and it may bring the same result as insufficient cleaning.

No.	Process	Condition
7	Coating and molding of the P.C.board	<ol> <li>When the P.C.board is coated, please verify the quality influence on the product.</li> <li>Please verify carefully that there is no harmful decomposing or reaction gas emission during curing which may damage the chip capacitors.</li> <li>Please verify the curing temperature.</li> </ol>
8	Handling after chip mounted	<ol> <li>Please pay attention not to bend or distort the P.C.board after soldering in handling otherwise the chip capacitors may crack.</li> <li>Bend</li> <li>Twist</li> </ol>
		<ul> <li>2) Printed circuit board cropping should not be carried out by hand, but by using the proper tooling. Printed circuit board cropping should be carried out using a board cropping jig as shown in the following figure or a board cropping apparatus to prevent inducing mechanical stress on the board.</li> <li>(1)Example of a board cropping jig Recommended example: The board should be pushed from the back side, close to the cropping jig so that the board is not bent and the stress applied to the capacitor is compressive. Unrecommended example: If the pushing point is far from the cropping jig and the pushing direction is from the front side of the board, large tensile stress is applied to the capacitor, which may cause cracks.</li> </ul>
		Outline of jig Printed circuit board Slot Board Slot Printed cropping jig Recommended Unrecommended Unrecommended Unrecommended Unrecommended Load point V-groove Slot

No.	Process	Condition						
8	Handling after chip mounted <u>(</u> Caution	<ul> <li>(2)Example of a board cropping machine</li> <li>An outline of a printed circuit board cropping machine is shown below. The top and bottom blades are aligned with one another along the lines with the V-grooves on printed circuit board when cropping the board.</li> <li>Unrecommended example: Misalignment of blade position between top and bottom, right and left, or front and rear blades may cause a crack in the capacitor.</li> </ul>						
		Outline of machine     Principle of operation       Image: Construction of the section diagram     Principle of operation						
					Printed circuit bo		blade	
			Recommended Top blade Board Board Bottom blade	Unrecommended				
				Top-bottom misalignment	Left-right misalignment	Front-rear misalignment		
				Top blade	Top blade	Top blade		
		to be adju	nctional check of f usted higher for fo I the P.C.board, it ons off. Please ac	ear of loose cor may crack the	ntact. But if the chip capacitor	e pressure is exc rs or peel the	essive	
		Item	Item Not recommended			Recommended		
		Board bending	Termination peeling Check pin			Support pin		

No.	Process	Condition			
9	Handling of loose chip capacitors	<ul> <li>1) If dropped the chip capacitors may crack. Once dropped do not use it. Especially, the large case sized chip capacitors are tendency to have cracks easily, so please handle with care.</li> <li>Crack</li> <li>Piling the P.C.board after mounting for storage or handling, the corner of the P.C. board may hit the chip capacitors of another board to cause crack.</li> </ul>			
10	Capacitance aging	The capacitors have aging in the capacitance. They may not be used in precision time constant circuit. In case of the time constant circuit, the evaluation should be done well.			
11	Estimated life and estimated failure rate of capacitors	As per the estimated life and the estimated failure rate depend on the temperature and the voltage. This can be calculated by the equation described in JEITA RCR-2335C Annex F(Informative) Calculation of the estimated lifetime and the estimated failure rate (Voltage acceleration coefficient : 3 multiplication rule, Temperature acceleration coefficient : 10°C rule) The failure rate can be decreased by reducing the temperature and the voltage but they will not be guaranteed.			
12	Caution during operation of equipment	<ol> <li>A capacitor shall not be touched directly with bare hands during operation in order to avoid electric shock. Electric energy held by the capacitor may be discharged through the human body when touched with a bare hand. Even when the equipment is off, a capacitor may stay charged. The capacitor should be handled after being completely discharged using a resistor.</li> <li>The terminals of a capacitor shall not be short-circuited by any accidental contact with a conductive object. A capacitor shall not be exposed to a conductive liquid such as an acid or alkali solution. A conductive object or liquid, such as acid and alkali, between the terminals may lead to the breakdown of a capacitor due to short circuit</li> <li>Confirm that the environment to which the equipment will be exposed during transportation and operation meets the specified conditions. Do not to use the equipment in the following environments.</li> <li>Environment where a capacitor is exposed to direct sunlight</li> <li>Environment where a capacitor exposed to Ozone, ultraviolet rays or radiation</li> <li>Environment where a capacitor exposed to corrosive gas(e.g. hydrogen sulfide, sulfur dioxide, chlorine. ammonia gas etc.)</li> <li>Environment where a capacitor exposed to vibration or mechanical shock exceeding the specified limits.</li> </ol>			

No.	Process	Condition				
13	Others	The products listed on this specification sheet are intended for use in general electronic equipment (AV equipment, telecommunications equipment, home appliances, amusement equipment, computer equipment, personal equipment, office equipment, measurement equipment, industrial robots) under a normal operation and use condition.				
		The products are not designed or warranted to meet the requirements of the applications listed below, whose performance and/or quality require a more stringent level of safety or reliability, or whose failure, malfunction or trouble could cause serious damage to society, person or property. Please understand that we are not responsible for any damage or liability caused by use of the products in any of the applications below or for any other use exceeding the range or conditions set forth in this specification sheet. If you intend to use the products in the applications listed below or if you have special requirements exceeding the range or conditions set forth in this specification, please contact us.				
		<ul> <li>(1)Aerospace/Aviation equipment</li> <li>(2)Transportation equipment (cars, electric trains, ships, etc.)</li> <li>(3)Medical equipment (Excepting Pharmaceutical Affairs Law classification Class1, 2)</li> <li>(4)Power-generation control equipment</li> <li>(5)Atomic energy-related equipment</li> <li>(6)Seabed equipment</li> <li>(7)Transportation control equipment</li> <li>(8)Public information-processing equipment</li> <li>(9)Military equipment</li> <li>(10)Electric heating apparatus, burning equipment</li> <li>(11)Disaster prevention/crime prevention equipment</li> <li>(12)Safety equipment</li> <li>(13)Other-applications that are not considered general purpose applications.</li> </ul>				
		When designing your equipment even for general-purpose applications, you are kindly requested to take into consideration securing protection circuit/device or providing backup circuits in your equipment.				

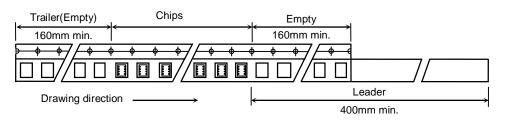
# **12. TAPE PACKAGING SPECIFICATION**

### **1. CONSTRUCTION AND DIMENSION OF TAPING**

1-1. Dimensions of carrier tape

Dimensions of plastic tape shall be according to Appendix 2.

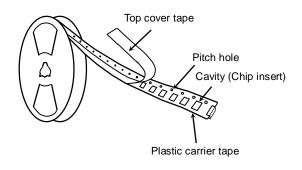
### 1-2. Trailer and leader of carrier tape



1-3. Dimensions of taping reel

Dimensions of Ø178mm diameter reel shall be according to Appendix 3. Dimensions of Ø330mm diameter reel shall be according to Appendix 4.

1-4. Structure of taping

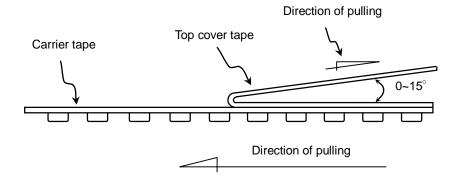


### 2. CHIP QUANTITY

Please refer to detail page on TDK Web.

### 3. PERFORMANCE SPECIFICATIONS

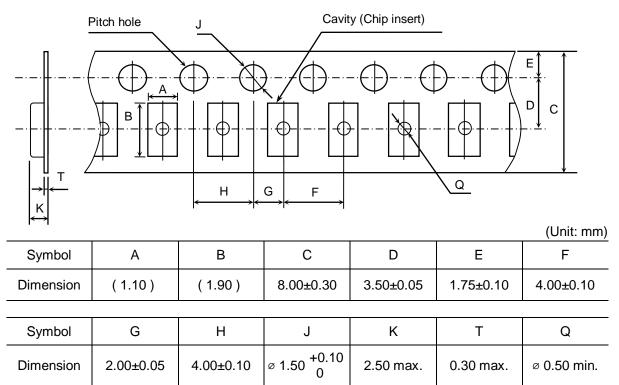
3-1. Peel back strength (top cover tape) 0.05N < Peeling strength < 0.7N



- 3-2. Carrier tape shall be flexible enough to be wound around a minimum radius of 30mm with components in tape.
- 3-3. The missing of components shall be less than 0.1%
- 3-4. Components shall not stick to fixing tape.
- 3-5. When removing the cover tape, there shall not be difficulties by unfitting clearance gap, burrs and crushes of cavities. Also the sprocket holes shall not be covered by absorbing dust into the suction nozzle.

# Appendix 2

### Plastic tape



() Reference value.

<b>Appendix 3</b> <u>Dimensions of reel</u> (Material : Polystyrene)								
		R	E c D		W <sub>2</sub> B B W <sub>1</sub> W <sub>1</sub>	(Unit: mm)		
Symbol	А	В	С	D	E	W <sub>1</sub>		
Dimension	ø 178 ± 2.0	Ø 60 ± 2.0	ø 13 ± 0.5	ø 21 ± 0.8	2.0 ± 0.5	9.0 ± 0.3		
Symbol	W <sub>2</sub>	R						
Dimension	13.0 ± 1.4	1.0						

Appendix 4
<u>Dimensions of reel</u> (Material : Polystyrene)

